#1003

PTO/SB/08A

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE **STATEMENT**

(Use several sheets if necessary)

ATTY. DOCKET NO. JEV/KAR:1016.2019

SERIAL NO. 18549 (Cent. of 10/274-068)

APPLICANT

Randy J. Schwindt et al.

FILING DATE Herewith 10/02 GROUP 2829

Page	_ /	of 2		CE DESIGNATION NT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
E. 7K	AA	3,333,274	7/25/1967	Forcier			
EAK	AB	3,710,251	1/09/1973	Hagge, et al.			
E. P.K.	AC	4,115,736	9/19/1978	Tracy			
E. P.K.	AD	4,383,178	5/10/1983	Shibata, et al.			
E. M.K.	ΑE	4,532,423	7/30/1985	Tojo et al.			
E.7K.	AF	4,731,577	3/15/1988	Logan			
E.ZK.	AG	4,755,746	7/05/1988	Mallory, et al.			
E, PK,	АH	4,757,255	7/12/1988	Margozzi			
E.T.K.	AJ	4,758,785	7/19/1988	Rath			
E. DK.	ΑJ	4,771,234	9/13/1988	Cook, et al.			
E. Dr.K.	AK	4,845,426	7/04/1989	Nolan, et al.			
E. P.K.	AL	4,356,904	8/15/1989	Akagawa			
8.7K.	AM	4,884,026	11/28/1989	Hayakawa, et al.			
E. ax	AN	5,077,523	12/31/1991	Blanz			
E. Z.K.	АО	5,084,671	1/28/1992	Miyata, et al.			
EMK.	АР	5,220,277	6/15/1993	Reitinger			
E TK.	AQ	5,345,170	9/06/1994	Schwindt, et al.			
E. D.K.	AR	5,434,512	7/18/1995	Schwindt, et al.			
Enk.	AS	5,457,398	10/10/1995	Schwindt, et al.			
EAK	AT	5,532,609	07/02/1996	Harwood, et al.			
ENK	AU	5,663,653	09/02/1997	Schwindt, et al.		`	
8.2K	ΑV	6,232,789	05/15/2001	Schwindt			
E. F.K.	AW	6,335,628	01/01/2002	Schwindt, et al.			
E.K.	AX	6,492,822	12/10/2002	Schwindt, et al.			

FOREIGN PATENT DOCUMENTS

			1010111	ALEKT BOOGHESTI				$\overline{}$
							TRANSLA	ATION
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
	AY	201205	12/1986	Europe				#==
	1	-1-209380	8/23/1989	- Jopan -		 		+
	AZ	1-207300	-		<u> </u>	†	i e	
4	_ B∧ - -	2-220 453	9/1990	Japan				

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PTO/SB/08A	ATTY. DOCKET NO. JEV/KAR:1016.2019 SERIAL NO. 10/678549				
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS INFORMATION DISCLOSURE STATEMENT	APPLICANT Randy J. Schwindt et al.				
(Use several sheets if necessary)	FILING DATE Herewith 10/02/03	GROUP 2829			

Page	2 04	OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)
	B	Micromanipulator Company, Inc., "Test Station Accessories." (1983)
	oc	Micromanipulator Company, Inc., "Model 8000 Test Station" (1986)
	BD .	"Model TPO3000 Series Thermochuck® Systems," four page product note, Temptronic Corporation, Newton, MA (May 1992 or earlier)
E	BE _	
	OF-	"Application Note + Controlled Environment Enclosure," two-page application note, Temptronic Corporation, Newton, MA (May 1992 or earlier)
E	3G	Minemanipulator Company, Inc. "Model 8000 Test Station." (1988)
-	эн	Applicance, Harry F. Deposition transcript (pp. 61-67) with exhibits 581 A.B.C. describing Flexion AP-1 probe station sold in 1987 (May 1988)
	31	"Cross Section Signatone S-1240," one-page sketch prepared by Signatone counsel.
	3)	"S-1240," two-page product note, Signatone, San Jose, CA (February 1988 or earlier
	ж	Y: Yarnamoto, "A Compact Self Shielding Prober" IEEE Trans., Inst. and Mcas., Vol. 38, pp. 1088-1093 (1989)
	3L	Temptronic's "Guarded" Chuck, one page note describing guarding system of Temptronic Corporation of Newton, MA, dated 11/15/89.
	эм-	Beck & Tomann, "Chip Tester," IBM Technical Disclosure Bulletin, p. 4819 (January 1985).
	3N	Article by William Knauer entitled "Fixturing for Low-Current/Low Voltage Parametric Testing," appearing in Evaluation Engineering, (1990), pp. 150-153
	30	Hewlett Packard, "Application Note 356 HP 4142B Medular DC Source/Monitor Practical Application," (Nov. 1987), pp. 1-4
	3P	: Hewlett-Packard, H-P Model 4284A Precision LCR Meter, Operation Manual (December 1991)
EXAMINER	Ern	Pp. 1-2, 6-9 and 6-15 DATE CONSIDERED July 15, 2004
EXAMINER: conformance ar	Initial if refer	rence considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in lered. Include copy of this form with next communication to applicant.

Information Disclosure Statement -PTO/SB/08A Added page 2 of 2